

<b>Notice of References Cited</b>	Application/Control No. 10/788,620		Applicant(s)/Patent Under Reexamination SUN ET AL.	
	Examiner HEMANT PATEL		Art Unit 2614	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,747,970	06-2004	Lamb et al.	370/352
*	B	US-7,142,646	11-2006	Zafar et al.	379/88.17
*	C	US-7,283,620	10-2007	Adamczyk, Maria	379/88.13
*	D	US-2003/0174815	09-2003	Didcock et al.	379/88.13
*	E	US-2003/0174814	09-2003	Diacakis, Athanassios	379/80
*	F	US-6,707,890	03-2004	Gao et al.	379/88.12
*	G	US-6,351,464	02-2002	Galvin et al.	370/356
*	H	US-6,459,913	10-2002	Cloutier, Jocelyn	455/567
*	I	US-4,926,462	05-1990	Ladd et al.	379/88.26
*	J	US-5,557,659	09-1996	Hyde-Thomson, Henry C. A.	379/88.13
*	K	US-2002/0165000	11-2002	Fok, Kenny K.	455/466
*	L	US-6,574,480	06-2003	Foladare et al.	455/458
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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